

Notice of References Cited

Application/Control No.

10/532,727

Applicant(s)/Patent Under
Reexamination
OGURA ET AL.

Examiner

Anthony Weier

Art Unit

1781

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002-153211	05-2002	Japan		
	O					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Translation of Detailed Description of JP 2002-153211 (published 05-2002)
	V	
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